Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/727,811	STEFAN ET AL.		
Examiner	Art Unit		
Benjamin P. Geib	2181		

	SEARCHED				
Class	Subclass	Date	Examiner		
712	22	10/23/2006	BPG		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEARCH	STRATEGY	
	DATE	EXMR
East Search	10/23/2006	BPG
NPL Search (IEEE Xplore and Google Scholar)	10/23/2006	BPG
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